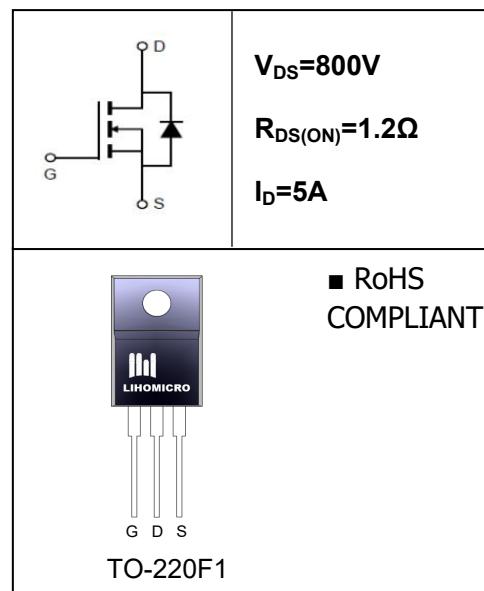


900V Super Junction MOSFET
•General Description

The SJ MOSFET LH90R1k4 has the low RDS(on), gate charge, fast switching and excellent avalanche characteristics. This device offers extremely fast and robust body diode, and is suitable for telecom and power supplies.


•Features

- Low Thermal Resistance
- Fast Switching
- High Input Resistance

•Application

- LED/LCD/PDP TV and monitor Lighting
- Power Supplies

•Ordering Information:

Part number	LH90R1K4		
Package	TO-220F1		
Basic ordering unit (pcs)	1000		
Normal Package Material Ordering Code	LH90R1K4F1-TO220F1-TU		
Halogen Free Ordering Code	LH90R1K4F1-TO220F1-TU-HF		

•Absolute Maximum Ratings (TC =25°C)

PARAMETER	SYMBOL	Value	UNIT
Drain-Source Breakdown Voltage ¹	BV_{DSS}	900	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current TC = 25°C TC = 100°C	I_D	5	A
		3.0	
Pulsed drain current (TC = 25°C, tp limited by Tjmax) ^{2,4}	I_{DM}	20	A
Single Pulse Avalanche Energy ²	E_{AS}	175	mJ
Power Dissipation(TC=25°C)	P_D	83	W
Peak Diode Recovery dv/dt ³	dv/dt	15	V/ns
Junction Temperature	T_J	-55~+150	°C
Storage Temperature	T_{STG}	-55~+150	°C

•Electronic Characteristics

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	900	--	--	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	--	4.0	V
Drain-source On Resistance ³	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 2.5A$	--	1.2	1.4	Ω
Drain-Source Leakage Current	I_{DSS}	$V_{DS} = 900V, V_{GS} = 0V, T_J = 25^\circ C$	--	--	1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS} = \pm 30V$	--	--	100	μA
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 400V, f = 1.0MHz$	--	480	--	pF
Output Capacitance	C_{oss}		--	428	--	
Reverse transfer Capacitance	C_{rss}		--	12	--	
Turn -Off Delay Time ³	$T_{d(off)}$	$V_{DD} = 720V, I_D = 1A, V_{GS} = 10V, R_G = 25\Omega$	--	49	--	ns
Turn -On Delay Time ³	$T_{d(on)}$		--	19	--	
Rise Time	T_r		--	23	--	
Fall Time	T_f		--	20	--	
Total Gate Charge	Q_g	$I_D = 5A, V_{DS} = 720V, V_{GS} = 0\sim 10V$	--	14	--	nC
Gate-to-Source Charge	Q_{gs}		--	3.5	--	
Gate-to-Drain Charge	Q_{gd}		--	6.0	---	

•Reverse Diode Characteristics

Continuous Diode Forward Current	I_s	--	--	--	5	A
Pulsed Diode Forward Current	I_{SM}	--	--	--	20	A
Diode Forward Voltage	V_{SD}	$I_s = 1A, V_{GS} = 0V$	--	--	1.4	V
Reverse Recovery Time	t_{rr}	$I_f = 11A, dI_f/dt = 100A/\mu s$	--	460	--	ns
Reverse Recovery Charge	Q_{rr}		--	2.7	--	μC

•Thermal Characteristics

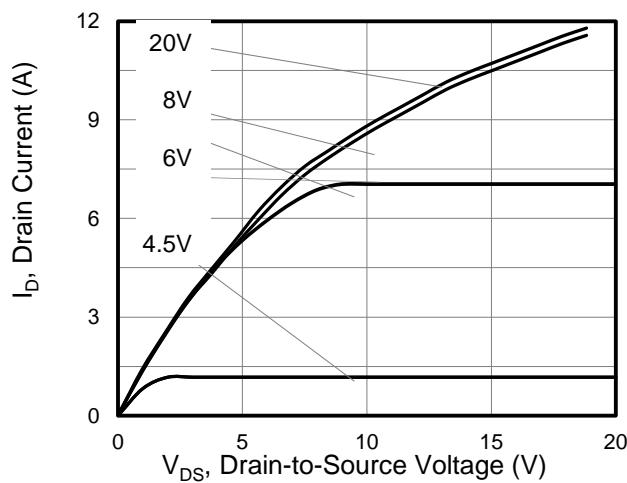
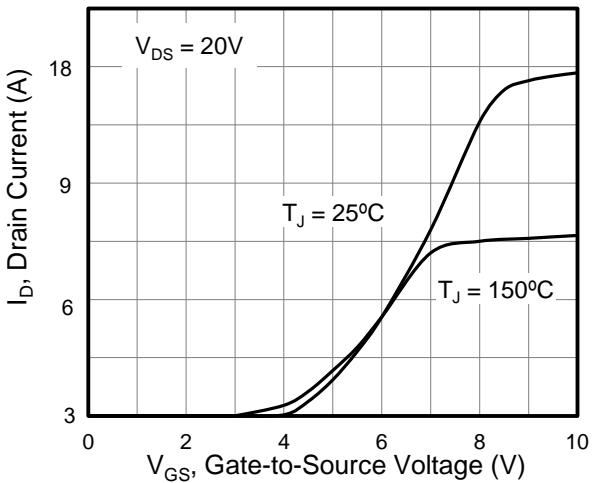
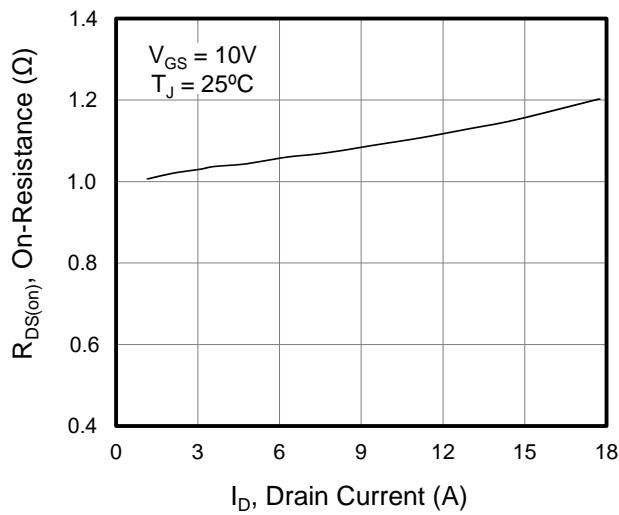
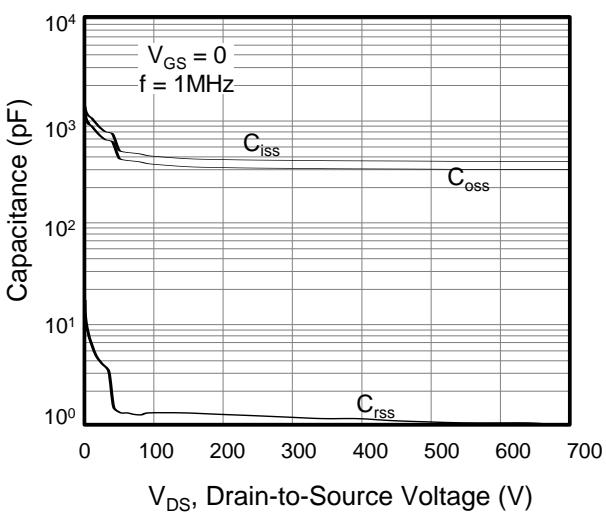
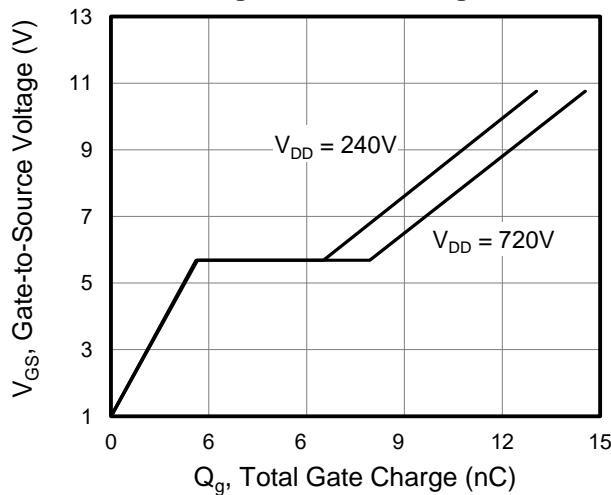
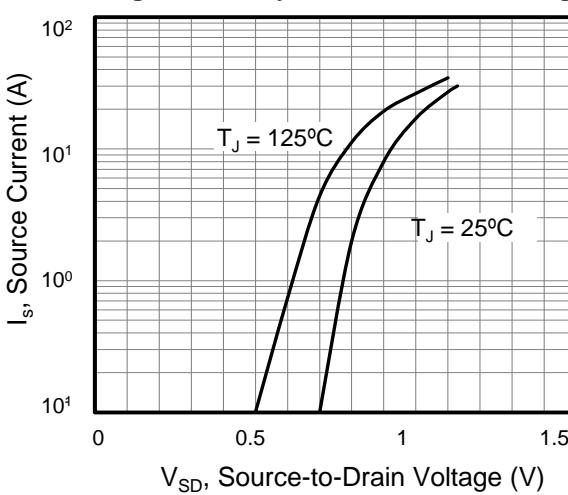
PARAMETER	SYMBOL	MAX	UNIT
Thermal Resistance Junction-case	R_{thJC}	1.5	$^\circ C/W$
Thermal Resistance Junction-ambient	R_{thJA}	62.5	$^\circ C/W$

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. $I_{AS} = 5A, V_{DD} = 50V, R_G = 25\Omega$, Starting $T_J = 25^\circ C$

3. Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

•Typical Characteristics
Figure 1. Output Characteristics

Figure 2. Transfer Characteristics

Figure 3. On-Resistance vs. Drain Current

Figure 4. Capacitance

Figure 5. Gate Charge

Figure 6. Body Diode Forward Voltage


- **Typical Characteristics(Cont.)**

Figure 7. On-Resistance vs. Junction Temperature

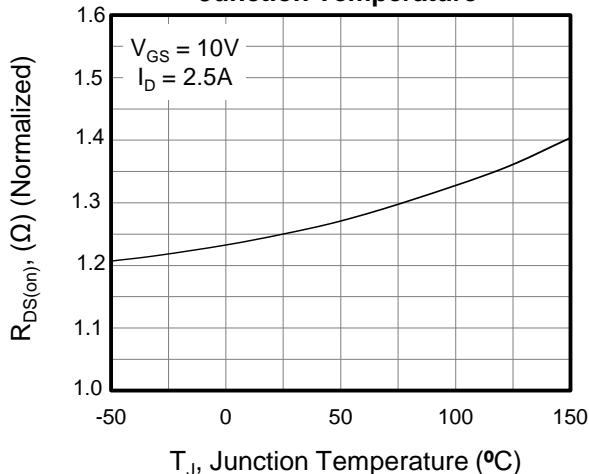


Figure 8. Breakdown voltage vs. Junction Temperature

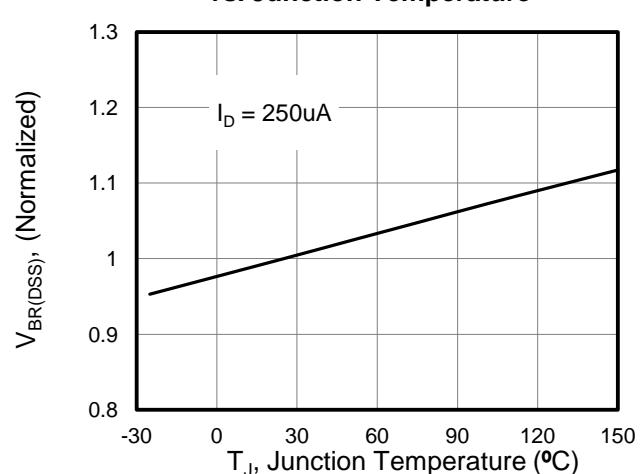


Figure 9. Transient Thermal Impedance

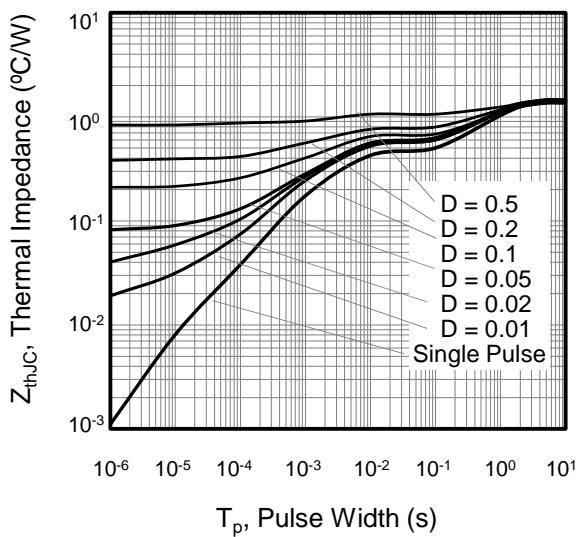
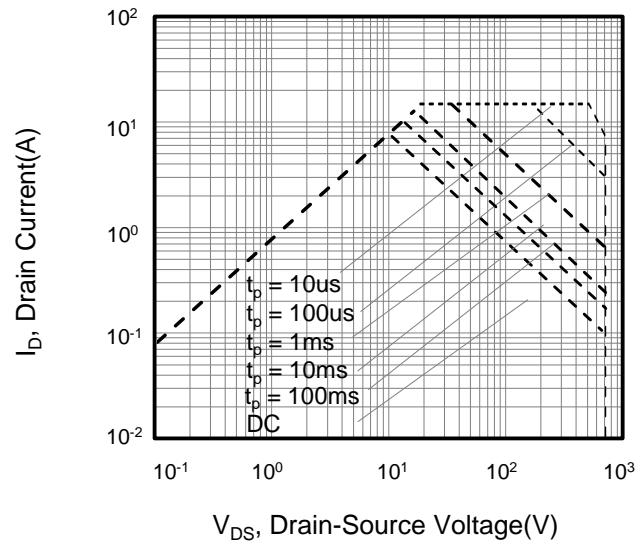
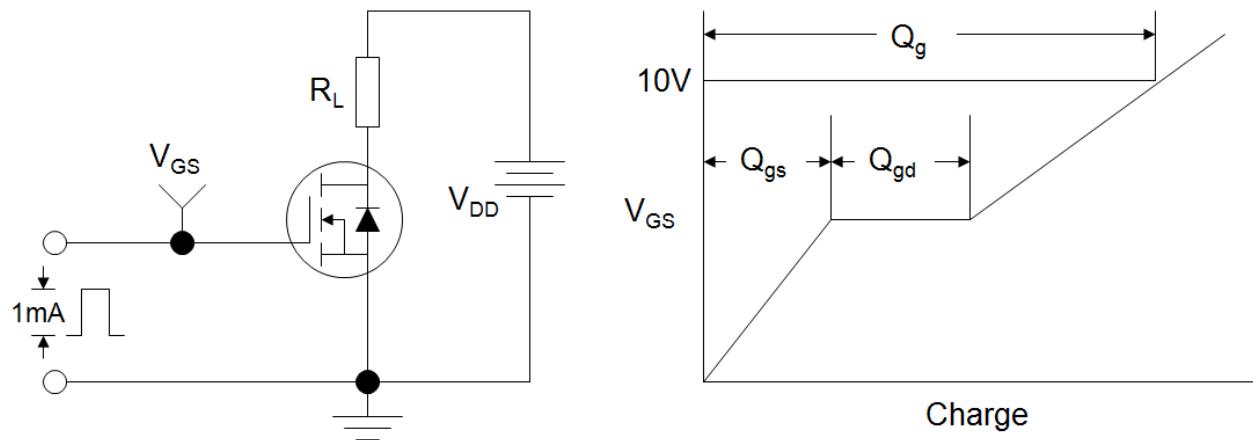
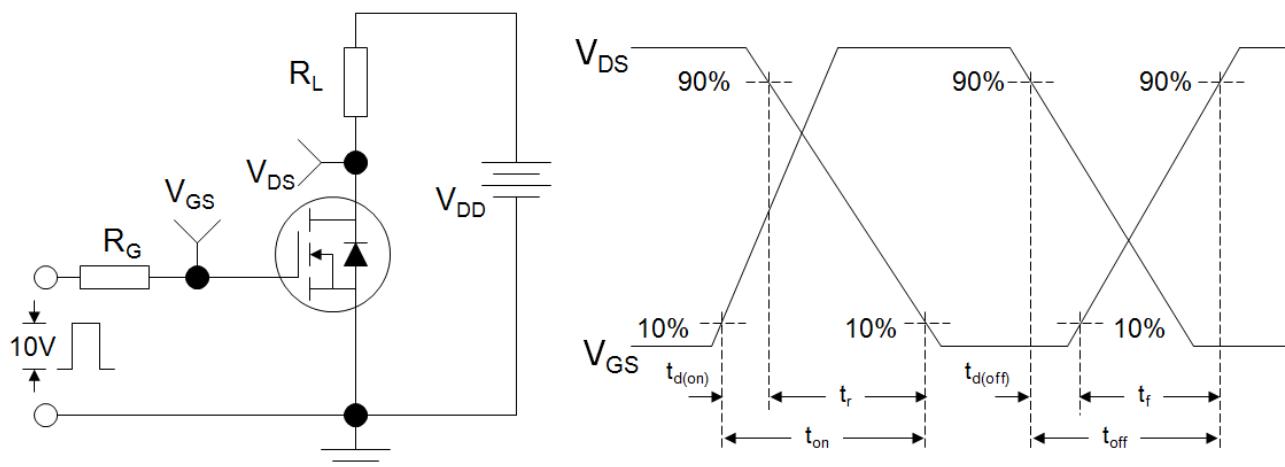
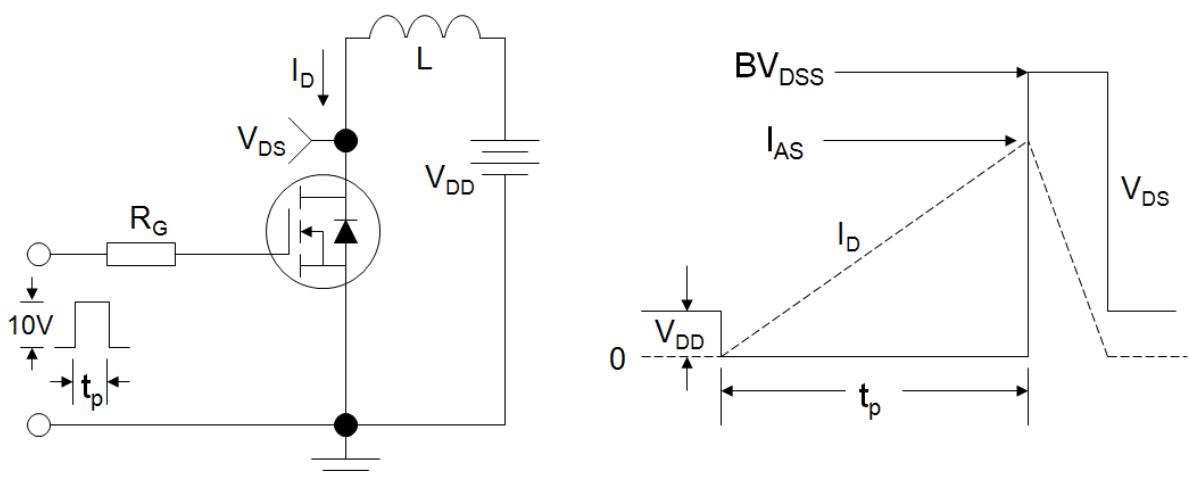


Figure 10. Safe operation area



• Test Circuit and Waveforms
Figure A: Gate Charge Test Circuit and Waveform

Figure B: Resistive Switching Test Circuit and Waveform

Figure C: Unclamped Inductive Switching Test Circuit and Waveform


•Dimensions (TO-220F1)

UNIT:mm

SYMBOL	min	max	SYMBOL	min	max
A	4.40	4.90	B1	2.90	3.70
A1	2.40	3.00	e	2.40	2.70
A2	2.30	3.00	e1	4.95	5.25
b	0.60	0.90	L	12.40	14.20
b1	1.10	1.70	L1	2.40	3.40
c	0.40	0.70	øP	2.90	3.50
D	9.80	10.60			
B	15.40	16.40			

